Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	181	257/533.ccls.	US-PGPUB; USPAT	OR	ON	2005/02/16 15:08
S2	1039	257/532.ccls. not (257/533.ccls.)	US-PGPUB; USPAT	OR	ON	2005/02/16 19:50
S3	504	257/536.ccls. not (257/532.ccls. 257/533.ccls.)	US-PGPUB; USPAT	OR	ON	2005/02/16 20:36
S4	173	257/534-535.ccls. not (257/536. ccls. 257/532.ccls.)	US-PGPUB; USPAT	OR	ON	2005/02/16 20:37
S5	115	257/534.ccls. not (257/536.ccls. 257/532.ccls. 257/533.ccls.)	US-PGPUB; USPAT	OR	ON	2005/02/16 20:37
S6	66	257/535.ccls. not (257/536.ccls. 257/532.ccls. 257/533.ccls.)	US-PGPUB; USPAT	OR	ON	2005/02/16 21:05
S7.	6633	decoupling near capacitor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:33
S8	105	S7 and (diffusion with electrode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 10:16
S9	67	chen-d\$.in. and capacitor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/16 21:18
S10	133	(decoupling near capacitor) and (diffusion with contacts)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:35
S11	6637	decoupling near capacitor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:35
S12	105	S11 and (diffusion with electrode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:35

S13	96	S10 not S12	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:36
S14	1756	capacitor and (low near (leakage loss)) and diffusion	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 10:17
S15	1035	S14 and (decoupl\$5 coupl\$5)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 10:18
S16	55	S15 and (contact? with resistance)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 10:18